

**Search Notes**

Application/Control No.

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Examiner

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**Applicant(s)/Patent under Reexamination**

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Art Unit

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	156.01-156.84	7/27/2005	HN
310	67R	7/27/2005	HN
310	68D	7/27/2005	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner